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Renesas Technology Corp. Customer Support Dept. April 1, 2003



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Silicon N/P Channel Power MOS FET High Speed Power Switching



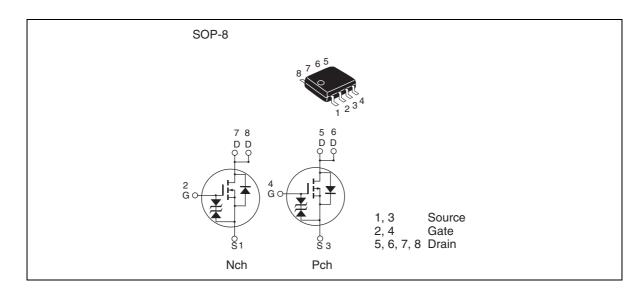
ADE-208-1402H (Z)

9th. Edition Aug. 2002

Features

- Low on-resistance
- Capable of 4.5 V gate drive
- High density mounting

Outline



Absolute Maximum Ratings

 $(Ta = 25^{\circ}C)$

Item	Symbol	Ratings		Unit
		Nch	Pch	_
Drain to source voltage	V _{DSS}	60	-60	V
Gate to source voltage	V _{GSS}	±20	±20	V
Drain current	I _D	6	– 5	A
Drain peak current	Note1 D(pulse)	48	-40	A
Body-drain diode reverse drain current	I _{DR}	6	– 5	A
Channel dissipation	Pch Note2	2	2	W
Channel dissipation	Pch Note3	3	3	W
Channel temperature	Tch	150	150	°C
Storage temperature	Tstg	-55 to +150	-55 to +150	°C

Notes: 1. PW \leq 10 μ s, duty cycle \leq 1 %

- 2. 1 Drive operation ; When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW \leq 10 s
- 3. 2 Drive operation; When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW \leq 10 s

Electrical Characteristics (Ta = 25°C)

• N Channel

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{_{(BR)DSS}}$	60	_	_	V	$I_{D} = 10 \text{ mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{\text{(BR)GSS}}$	±20	_	_	V	$I_{G} = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$
Zero gate voltage drain current	I _{DSS}	_	_	1	μΑ	$V_{DS} = 60 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{\text{GS(off)}}$	1.0	_	2.5	V	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$
Static drain to source on state	R _{DS(on)}	_	25	32	mΩ	$I_{D} = 3 \text{ A}, V_{GS} = 10 \text{ V}^{Note4}$
resistance	R _{DS(on)}	_	32	45	mΩ	$I_{\rm D} = 3 \text{ A}, V_{\rm GS} = 4.5 \text{ V}^{\rm Note4}$
Forward transfer admittance	ly _{fs} l	7	11	_	S	$I_{D} = 3 \text{ A}, V_{DS} = 10 \text{ V}^{Note4}$
Input capacitance	Ciss	_	1050	_	pF	V _{DS} = 10 V
Output capacitance	Coss	_	150	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	90	_	pF	f = 1 MHz
Turn-on delay time	t _{d(on)}	_	15	_	ns	$V_{GS} = 10 \text{ V}, I_{D} = 3 \text{ A}$
Rise time	t _r	_	15	_	ns	$V_{DD} \approx 30 \text{ V}$
Turn-off delay time	t _{d(off)}	_	55	_	ns	$R_L = 10 \Omega$
Fall time	t,	_	10	_	ns	$R_g = 4.7 \Omega$
Body-drain diode forward voltage	V _{DF}	_	0.85	1.10	V	$IF = 6 A$, $V_{GS} = 0$ Note4
Body-drain diode reverse recovery time	t _{rr}	_	50	_	ns	IF =6 A, V _{ss} = 0 diF/ dt =100 A/μs

Notes: 4. Pulse test

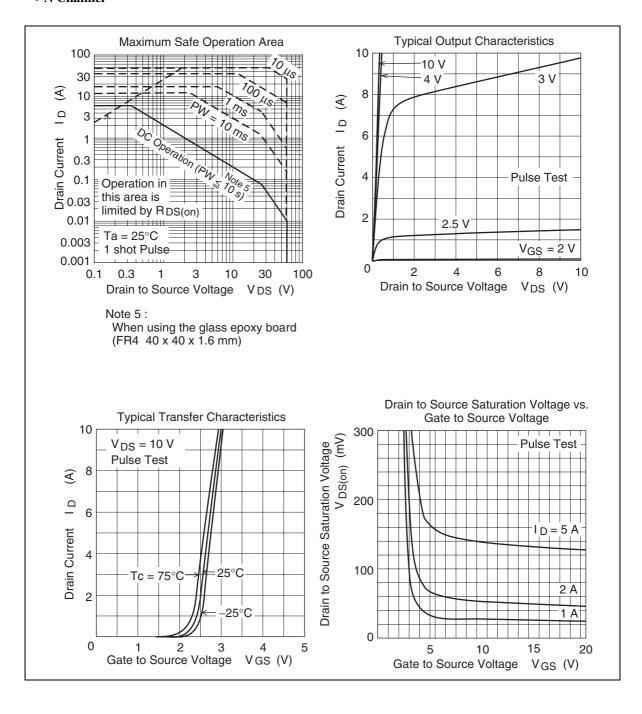
• P Channel

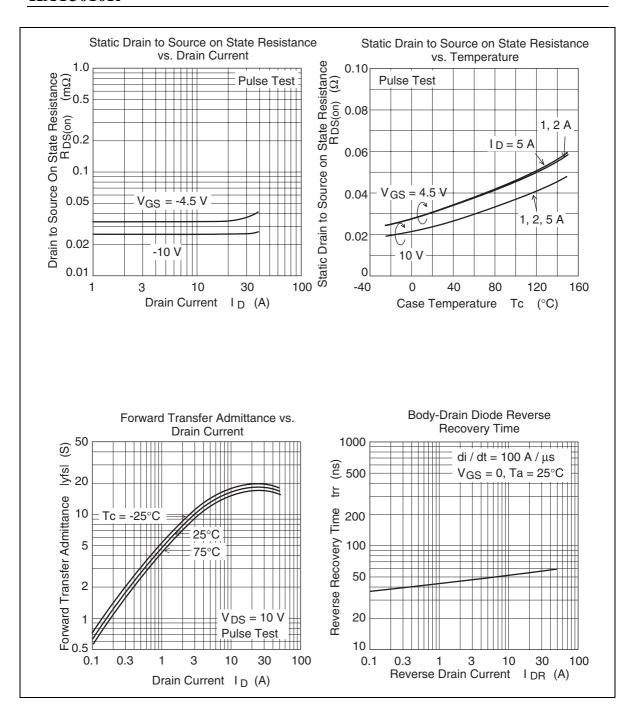
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{_{(BR)DSS}}$	-60	_	_	V	$I_{D} = -10 \text{ mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±20	_	_	V	$I_{_{G}} = \pm 100 \ \mu A, \ V_{_{DS}} = 0$
Gate to source leak current	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$
Zero gate voltage drain current	I _{DSS}	_	_	-1	μΑ	$V_{DS} = -60 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{\text{GS(off)}}$	-1.0	_	-2.5	V	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$
Static drain to source on state	$R_{\scriptscriptstyle DS(on)}$	_	60	76	mΩ	$I_{D} = -2.5 \text{ A}, V_{GS} = -10 \text{ V}^{Note5}$
resistance	R _{DS(on)}	_	90	130	mΩ	$I_{D} = -2.5 \text{ A}, V_{GS} = -4.5 \text{ V}^{Note5}$
Forward transfer admittance	ly _{fs} l	3	5	_	S	$I_{D} = -2.5 \text{ A}, V_{DS} = -10 \text{ V}^{Note5}$
Input capacitance	Ciss	_	1350	_	pF	V _{DS} = -10 V
Output capacitance	Coss	_	135	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	85	_	pF	f = 1 MHz
Turn-on delay time	$\mathbf{t}_{\text{d(on)}}$	_	20	_	ns	$V_{GS} = -10 \text{ V}, I_{D} = -2.5 \text{ A}$
Rise time	t _r	_	15	_	ns	$V_{DD} \approx -30 \text{ V}$
Turn-off delay time	t _{d(off)}	_	55	_	ns	$R_L = 12 \Omega$
Fall time	t,	_	10	_	ns	$R_g = 4.7 \Omega$
Body-drain diode forward voltage	V _{DF}	_	-0.85	-1.10	V	$IF = -5 A, V_{GS} = 0^{Note5}$
Body-drain diode reverse recovery time	t _{rr}	_	50	_	ns	$IF = -5 A$, $V_{GS} = 0$ diF/ dt = 100 A/ μ s

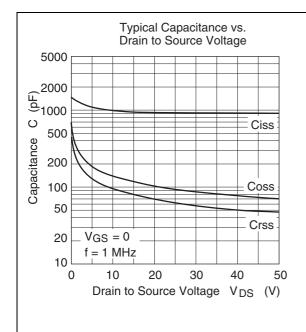
Notes: 5. Pulse test

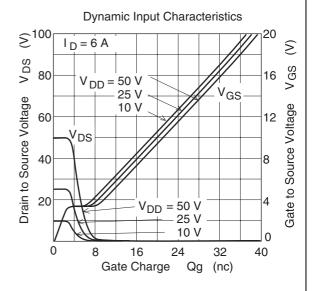
Main Charactristice

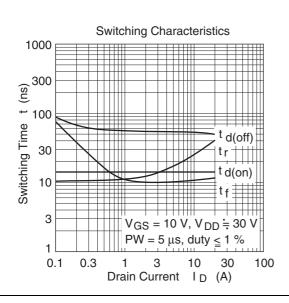
• N Channel

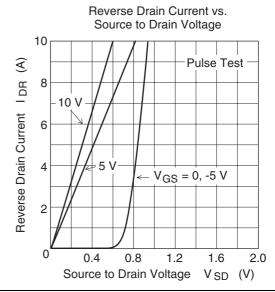




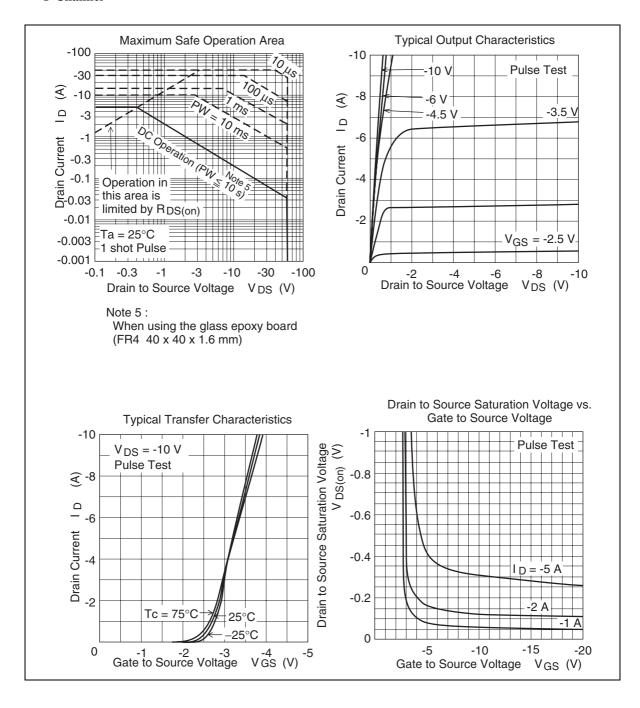


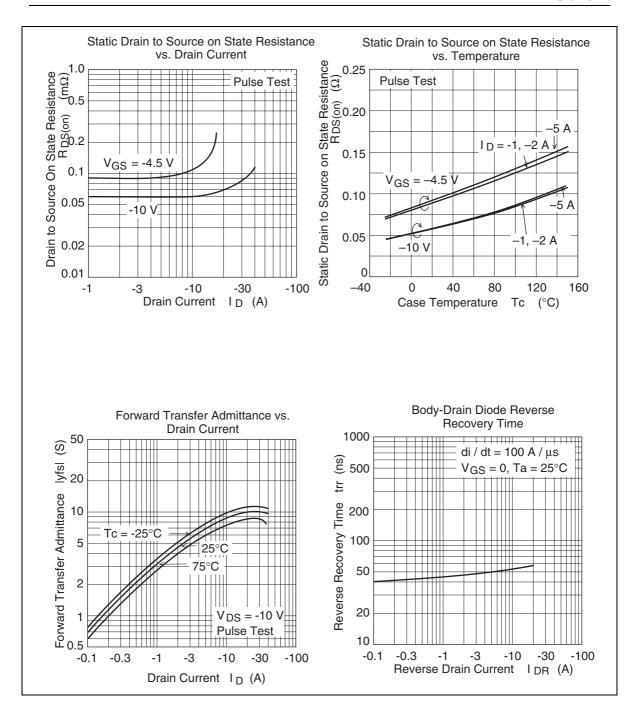


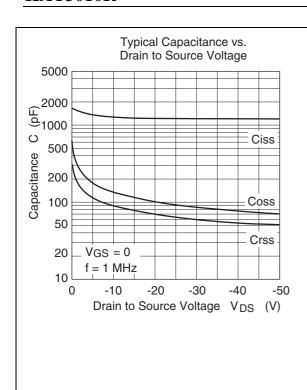


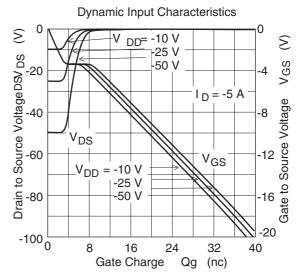


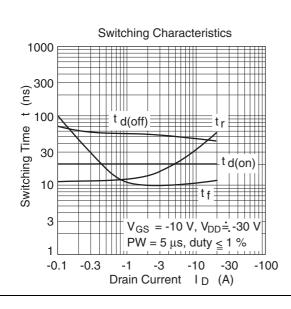
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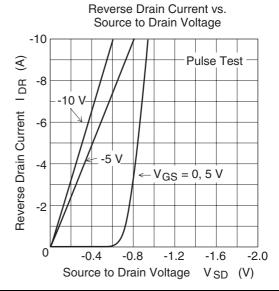


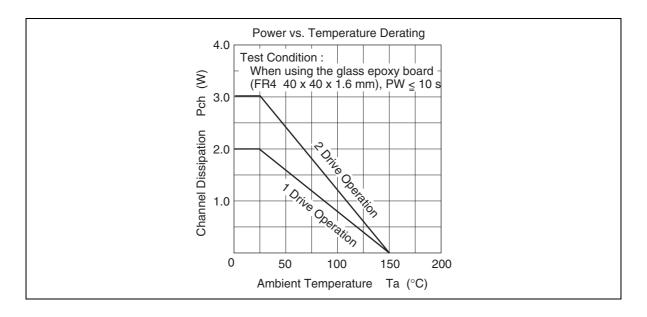


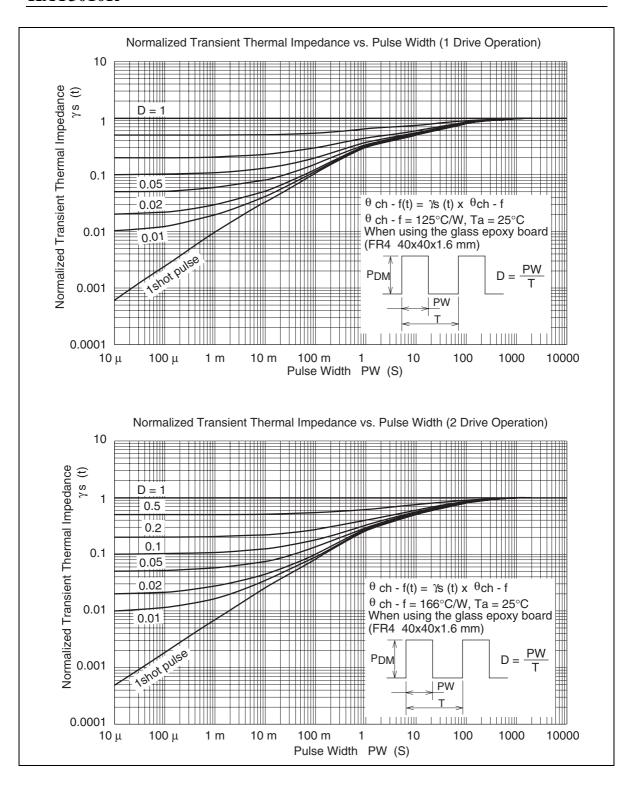




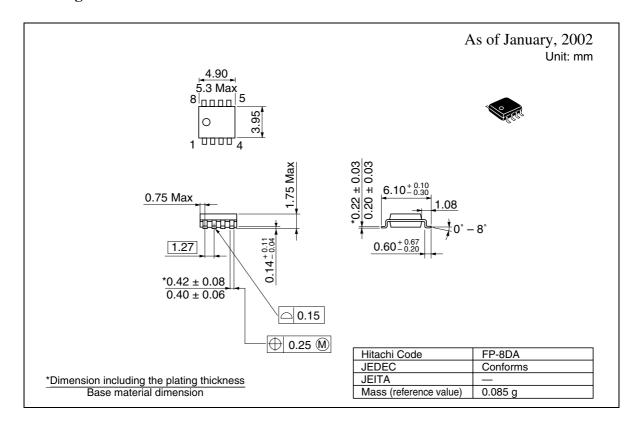








Package Dimensions



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